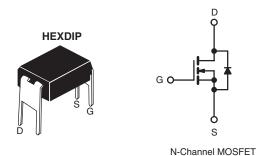


Vishay Siliconix

COMPLIANT

## **Power MOSFET**

| PRODUCT SUMMARY                 |                          |      |  |  |  |
|---------------------------------|--------------------------|------|--|--|--|
| V <sub>DS</sub> (V)             | 60                       |      |  |  |  |
| $R_{DS(on)}\left(\Omega\right)$ | $V_{GS} = 5.0 \text{ V}$ | 0.10 |  |  |  |
| Q <sub>g</sub> (Max.) (nC)      | 18                       |      |  |  |  |
| Q <sub>gs</sub> (nC)            | 4.5                      |      |  |  |  |
| Q <sub>gd</sub> (nC)            | 12                       |      |  |  |  |
| Configuration                   | Single                   |      |  |  |  |



### **FEATURES**

- Dynamic dV/dt Rating
- · For Automatic Insertion
- End Stackable
- · Logic-Level Gate Drive
- R<sub>DS(on)</sub> Specified at V<sub>GS</sub> = 4 V and 5 V
- 175 °C Operating Temperature
- · Fast Switching
- Lead (Pb)-free Available

### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertiable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain servers as a thermal link to the mounting surface for power dissipation levels up to 1 W.

| ORDERING INFORMATION |             |  |  |
|----------------------|-------------|--|--|
| Package              | HEXDIP      |  |  |
| Lead (Pb)-free       | IRLD024PbF  |  |  |
|                      | SiHLD024-E3 |  |  |
| SnPb                 | IRLD024     |  |  |
|                      | SiHLD024    |  |  |

| ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted |                          |                         |                                   |                  |      |  |
|---|--------------------------|-------------------------|-----------------------------------|------------------|------|--|
| PARAMETER   |                          |                         | SYMBOL                            | LIMIT            | UNIT |  |
| Drain-Source Voltage  |                          |                         | V <sub>DS</sub>                   | 60               |      |  |
| Gate-Source Voltage   |                          |                         | $V_{GS}$                          | ± 10             | V    |  |
| Continuous Drain Current  | V <sub>GS</sub> at 5.0 V | T <sub>C</sub> = 25 °C  | - I <sub>D</sub>                  | 2.5              | А    |  |
|   | VGS at 5.0 V             | T <sub>C</sub> = 100 °C |                                   | 1.8              |      |  |
| Pulsed Drain Current <sup>a</sup>                                       |                          |                         | I <sub>DM</sub>                   | 20               |      |  |
| Linear Derating Factor  |                          |                         |                                   | 0.0083           | W/°C |  |
| Single Pulse Avalanche Energy <sup>b</sup>                              |                          |                         | E <sub>AS</sub>                   | 91               | mJ   |  |
| Maximum Power Dissipation   | T <sub>C</sub> = 25 °C   |                         | P <sub>D</sub>                    | 1.3              | W    |  |
| Peak Diode Recovery dV/dt <sup>c</sup>                                  |                          |                         | dV/dt                             | 4.5              | V/ns |  |
| Operating Junction and Storage Temperature Range                        |                          |                         | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 175    |      |  |
| Soldering Recommendations (Peak Temperature)                            | for 10 s                 |                         |                                   | 300 <sup>d</sup> | °C   |  |

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 16 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 2.5 A (see fig. 12).
- c.  $I_{SD} \leq$  17 A,  $dI/dt \leq$  140 A/ $\mu$ s,  $V_{DD} \leq$   $V_{DS}$ ,  $T_{J} \leq$  175 °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRLD024, SiHLD024

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| THERMAL RESISTANCE RATINGS  |            |      |      |      |  |
|-----------------------------|------------|------|------|------|--|
| PARAMETER                   | SYMBOL     | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient | $R_{thJA}$ | -    | 120  | °C/W |  |

| PARAMETER                                 | SYMBOL                           | TES   | MIN.  | TYP. | MAX.  | UNIT     |      |
|---|----------------------------------|---|---|------|-------|----------|------|
| Static                                    |                                  | _   |   |      |       |          |      |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>                  | V <sub>GS</sub> =   | 60  | -    | -     | V        |      |
| V <sub>DS</sub> Temperature Coefficient   | ΔV <sub>DS</sub> /T <sub>J</sub> | Reference   | Reference to 25 °C, I <sub>D</sub> = 1 mA   |      | 0.060 | -        | V/°C |
| Gate-Source Threshold Voltage             | V <sub>GS(th)</sub>              | V <sub>DS</sub> =   | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA   |      | -     | 2.0      | V    |
| Gate-Source Leakage                       | I <sub>GSS</sub>                 | ,   | V <sub>GS</sub> = ± 10 V  |      | -     | ± 100    | nA   |
|   |                                  | V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V   |   | -    | -     | 25       | μΑ   |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>                 | V <sub>DS</sub> = 48 V,   | V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C                              |      | -     | 250      |      |
|   |                                  | V <sub>GS</sub> = 5.0 V   | I <sub>D</sub> = 1.5A <sup>b</sup>  | -    | -     | 0.10     | Ω    |
| Drain-Source On-State Resistance          | $R_{DS(on)}$                     | V <sub>GS</sub> = 4.0 V   | I <sub>D</sub> = 1.3 A <sup>b</sup>   | -    | -     | 0.14     |      |
| Forward Transconductance                  | 9 <sub>fs</sub>                  | V <sub>DS</sub> = 25 V, I <sub>D</sub> = 1.5 A <sup>b</sup>                           |   | 3.7  | -     | -        | S    |
| Dynamic                                   |                                  |   |   | •    |       | <u>'</u> |      |
| Input Capacitance                         | C <sub>iss</sub>                 | $V_{GS} = 0 \text{ V}$ $V_{DS} = 25 \text{ V}$ f = 1.0 MHz, see fig. 5                |   | -    | 870   | -        | pF   |
| Output Capacitance                        | C <sub>oss</sub>                 |   |   | -    | 360   | -        |      |
| Reverse Transfer Capacitance              | C <sub>rss</sub>                 |   |   | -    | 53    | -        |      |
| Total Gate Charge                         | Qg                               |   |   | -    | -     | 18       |      |
| Gate-Source Charge                        | Q <sub>gs</sub>                  | V <sub>GS</sub> = 5.0 V   | $V_{GS} = 5.0 \text{ V}$ $I_D = 17 \text{ A}, V_{DS} = 48 \text{ V}$ see fig. 6 and 13 <sup>b</sup> |      | -     | 4.5      | nC   |
| Gate-Drain Charge                         | $Q_{gd}$                         |   | goo ngi o ana 10  | -    | -     | 12       | 1    |
| Turn-On Delay Time                        | t <sub>d(on)</sub>               |   |   | -    | 11    | -        | - ns |
| Rise Time                                 | t <sub>r</sub>                   | Von   | V <sub>DD</sub> = 30 V, I <sub>D</sub> = 17 A   |      | 110   | -        |      |
| Turn-Off Delay Time                       | t <sub>d(off)</sub>              | $R_G = 9.0 \Omega$ , $R_D = 1.7 \Omega$ , see fig. $10^b$                             |   | -    | 23    | -        |      |
| Fall Time                                 | t <sub>f</sub>                   |   |   | -    | 41    | -        |      |
| Internal Drain Inductance                 | L <sub>D</sub>                   | Between lead,<br>6 mm (0.25") from<br>package and center of<br>die contact            |   | -    | 4.0   | -        | - nH |
| Internal Source Inductance                | L <sub>S</sub>                   |   |   | -    | 6.0   | -        |      |
| Drain-Source Body Diode Characteristic    | s                                | 1   |   |      |       |          |      |
| Continuous Source-Drain Diode Current     | I <sub>S</sub>                   | MOSFET symbol showing the integral reverse p - n junction diode                       |   | -    | -     | 2.5      | - A  |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>                  |   |   | -    | -     | 20       |      |
| Body Diode Voltage                        | V <sub>SD</sub>                  | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 2.5 A, V <sub>GS</sub> = 0 V <sup>b</sup>    |   | -    | -     | 1.5      | V    |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>                  | T <sub>J</sub> = 25 °C, I <sub>F</sub> = 17 A, dl/dt = 100 A/μs <sup>b</sup>          |   | -    | 110   | 260      | ns   |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>                  |   |   | -    | 0.49  | 1.5      | μС   |
| Forward Turn-On Time                      | t <sub>on</sub>                  | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_{\bar{L}}$ |   |      |       | <br>LD)  |      |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

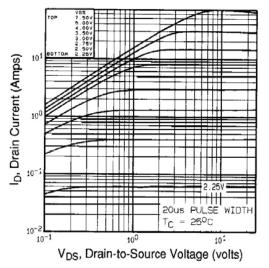


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

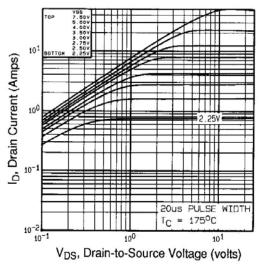


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 175 °C

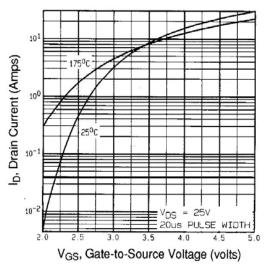


Fig. 3 - Typical Transfer Characteristics

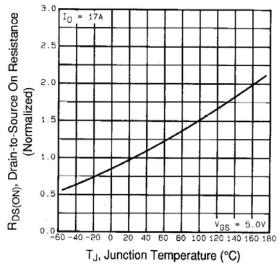


Fig. 4 - Normalized On-Resistance vs. Temperature

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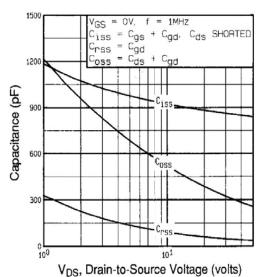


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

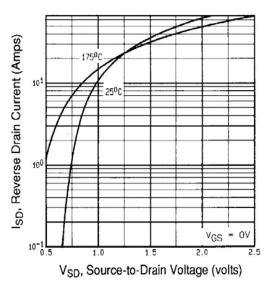


Fig. 7 - Typical Source-Drain Diode Forward Voltage

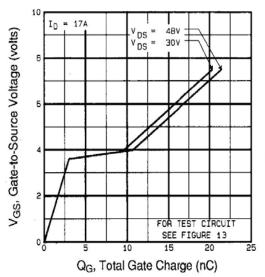


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

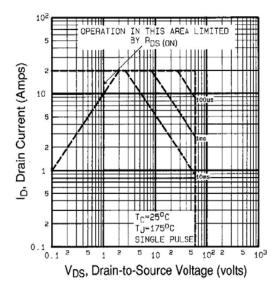


Fig. 8 - Maximum Safe Operating Area





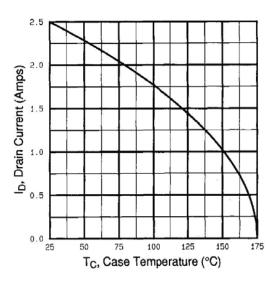


Fig. 9 - Maximum Drain Current vs. Case Temperature

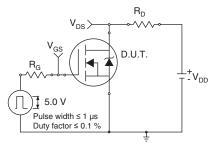


Fig. 10a - Switching Time Test Circuit

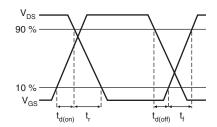


Fig. 10b - Switching Time Waveforms

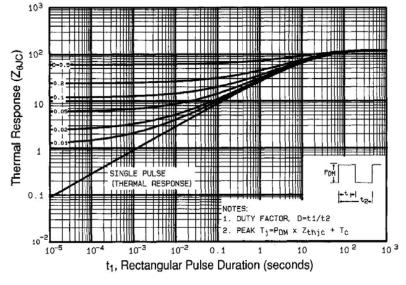


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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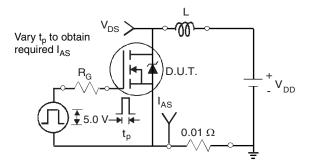


Fig. 12a - Unclamped Inductive Test Circuit

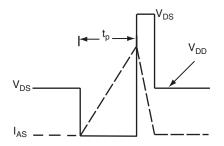


Fig. 12b - Unclamped Inductive Waveforms

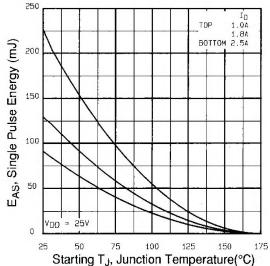


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

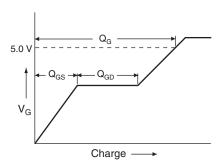


Fig. 13a - Basic Gate Charge Waveform

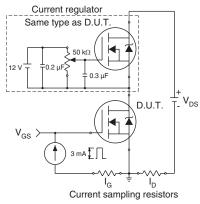
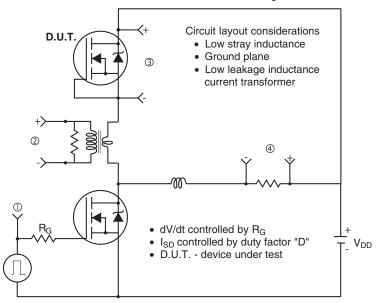
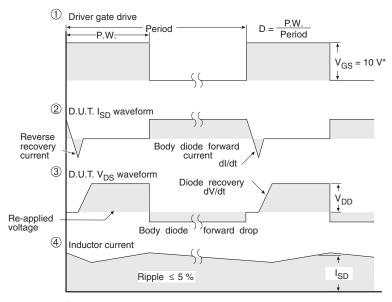


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit





\* V<sub>GS</sub> = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com